1. Introduction

Recently, visible-light-driven photocatalysis has been regarded as an efficient renewable route for environmental remediation such as providing clean air and water sources by removing organic pollutants. In this regard, semiconductor-based photocatalysts, which can efficiently absorb and utilize visible light for the photodegradation of the organic compounds/molecules, have attracted much interest. Most of the studies have focused on anatase crystalline TiO$_2$, which exhibits high photocatalytic activity and high chemical stability under ultraviolet (UV) light irradiation, the wavelength of which is below 387 nm with a respective energy bandgap of about 3.2 eV. Despite this, because of its wide optical bandgap TiO$_2$ can only utilize 5% of the solar spectrum (UV light). In contrast, investigations of the visible light driven photocatalytic materials are emerging because of their efficient use of a large proportion (44%) of the solar spectrum. Tungsten oxide (WO$_3$), an n-type semiconductor with an optical bandgap of 2.6 to 2.8 eV exhibits particularly promising photocatalytic performance under visible light ($\lambda > 380$ nm). In addition, WO$_3$ is well known for its stable physicochemical properties, good thermal stability, and resilience to photocorrosion effects. However, pure WO$_3$ has having limitations such as low conduction band level, which inhibits the ability to react with electron acceptors. Moreover, the fast recombination rate of photogenerated electron–hole pairs. Unlike the powder-based photocatalysts, the reported thin film-based heterojunction photocatalyst could be very sustainable and cost-effective.

Fabrication of Ag$_2$O/WO$_3$ p–n heterojunction composite thin films by magnetron sputtering for visible light photocatalysis

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Semiconductor-based nanostructures which are photocatalytically active upon solar light irradiation were extensively used for environmental remediation due to the potential decomposition of various kinds of pollutants. In this work, we report the preparation of a sustainable thin film composite, i.e. Ag$_2$O/WO$_3$ p–n heterojunction, and investigation of its photocatalytic activity. To achieve the composite structure, WO$_3$/Ag–WO$_3$ layers were deposited over a quartz substrate by magnetron sputtering at room temperature and subsequently annealed at 823 to 923 K. The thin film structure, morphology, and chemical states were thoroughly characterized by X-ray diffraction, field-emission scanning electron microscopy, transmission electron spectroscopy, and X-ray photoelectron spectroscopy. The obtained results revealed that the amorphous Ag-doped WO$_3$ was crystallized into monoclinic WO$_3$ and Ag$_2$O, in which nanocrystalline Ag$_2$O was diffused towards the surface of WO$_3$. Optical transmittance spectra recorded by UV-vis-NIR spectroscopy revealed that the WO$_3$/Ag–WO$_3$ films became transparent in the visible region after annealing at high temperature (873 K and 923 K). The Ag$_2$O/WO$_3$ p–n heterojunction composite thin films showed high photocatalytic activity ($0.915 \times 10^{-3}$ min$^{-1}$) under visible light irradiation, which is attributed to the efficiency of effective photogenerated charge-carrier formation and the reduced recombination rate of photogenerated electron–hole pairs. Unlike the powder-based photocatalysts, the reported thin film-based heterojunction photocatalyst could be very sustainable and cost-effective.

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several researchers reported various p–n heterojunction photocatalysts such as $x$–$Fe_2O_3$/Cu$_2$O, $Ag_2O/Bi_2O_3CO_3$, $Ag_3PO_4/\text{WO}_3$, $Fe_2O_3/Bi_2O_3CO_3$, TiO$_2$/NiO, $WO_3/Ag_2CO_3$, and $WO_3$/BiOI. Irrespective of the strategy that was implemented to improve the photocatalytic activity, most of these studies are powder-based photocatalytic materials. Despite, the investigations on thin film-based photocatalysts have been rarely reported. For advanced photocatalytic applications, it is essential to eliminate the separation activity in which the powder-based photocatalysts need repeated separation process from the polluted water. Therefore, the design of an efficient thin film coating-based photocatalysts which can easily separate the electron–hole pair that exhibits promising photocatalytic activity without any additional separation procedures, unlike the powder-based photocatalysts is the emerging for sustainable practical environmental applications. Various physical methods have been reported to fabricate $WO_3$ thin films such as sol–gel, electrodeposition, atomic layer deposition, dip-coating, thermal evaporation and sputtering. Among these techniques, the magnetron sputtering is a unique method for the fabrication of large-scale high-quality thin film coatings.

In this work, we propose a novel sputter-deposited $p$–$n$ heterojunction thin film nanostructures formed by $Ag_2O$ and $WO_3$ in which $Ag_2O$ nanosheet-like structures embedded in the monoclinic $WO_3$ phase for an $e$–$h$ heterojunction with $WO_3$ due to its high $e$–$h$ separation rate of photogenerated electron–hole pairs. $Ag_2O$, a $p$-type direct bandgap semiconductor with a reported optical bandgap $\sim 1.46$ eV, which can be suitable to form a prominent $p$–$n$ heterojunction with $WO_3$ due to its high efficiency, controllability and ease of fabrication. For example, Zhou et al. has demonstrated a high photocatalytic activity with a $p$–$n$ heterojunction formed by $Ag_2O/TiO_2$ nanobelts driven both UV and visible light for the degradation of methyl orange (MO). Similarly, $Ag_2O$-based heterojunction structures $Ag_2O/BiWO_4$, $Ag_2O/g-C_3N_4$, $Ag_2O/Ag_2CO_3$, $Ag_2O/CeO_2$, ZnO/$Ag_2O$, and $Ag_2O/\text{Bi}_2\text{MoO}_6$ were successfully demonstrated by the other researchers for visible light photocatalysis. In this work, nanosheet-like $Ag_2O$ was chosen with the combination of $WO_3$ because it is advantageous in not only improving the photocatalytic activity but also allows the thin film apparently transparent due to the homogeneous spatial distribution of $Ag_2O$ in $WO_3$. The visible-light-driven photocatalytic activity of the $WO_3$/Ag–$WO_3$ films was evaluated by the photodegradation of methylene blue (MB), and the relations with enhanced photocatalytic properties and microstructure evolution were investigated.

2. Experimental section

Tungsten oxide thin films were deposited over the quartz glass substrate with a $WO_3$ target of 99.999% purity (2 in diameter) at room temperature by using radio frequency (RF) magnetron sputtering. Prior to sputtering, the base pressure of the sputtering chamber was pumped down to $2 \times 10^{-6}$ Torr using a turbomolecular pump. Argon (Ar) of 99.999% purity was used as a sputtering gas, 230 sccm Ar gas was input into the chamber through the mass flow controller. Sputtering power 150 W was supplied to the target, and distance between the sputter target and the substrate was fixed at 90 mm. Ag-doped (Ag–$WO_3$) films were prepared by sputtering with a mosaic target in which small Ag chips (2 chips, size: $1 \text{ mm} \times 1 \text{ mm} \times 0.5 \text{ mm}$) embedded over the surface of the $WO_3$ target. The same sputtering conditions were maintained for both the pure $WO_3$ films and Ag–$WO_3$ films. Finally, $WO_3$/quartz and $WO_3$/Ag–$WO_3$/quartz thin films were deposited and subsequently annealed at 823 K to 923 K in air ambient for 1 h using a Rapid Thermal Annealing (RTA) system.

The structural properties of the films were investigated by X-ray diffraction (XRD) with Bruker X-ray diffractometer using Cu-Kz radiation ($\lambda = 1.5406$ Å), the X-ray source was operated at 40 kV and 30 mA. The UV-visible absorbance spectra and transmittance spectra were recorded in the range of 300 to 1900 nm by using UV-vis-NIR spectrophotometer (UV-3600, Shimadzu, Japan). The surface morphology and cross-sectional structure of the thin films were investigated by using field-emission scanning electron microscopy (FESEM, TESCAN MIRA3, Korea). Thin film cross-section was investigated by transmission electron microscopy (TEM, Tecnai G2 F20, Thermo Fisher, USA) with energy dispersive X-ray (EDX) analyzers, the samples were prepared by a focused ion-beam system for the TEM observation. X-ray photoelectron spectroscopy (XPS) was carried out using Al Kz X-ray with constant analyzer mode. The photoluminescence properties were studied by using a PerkinElmer LS-50B luminescence spectrometer. Photocatalytic activity of the prepared thin films was investigated by measuring the degree of decomposition of methylene blue (20 ml MB solution, 10 ppm) under visible light illuminated by Xe-lamp 500 W with a 400 nm filter. To maintain the constant temperature of the MB solution, cooled water was continuously circulated via double-walled photoreactor. The photocatalytic degradation of MB has been evaluated from the decrease in the absorption intensity of MB at the wavelength of 664 nm. The photocatalytic degradation efficiency has been evaluated using the following equation.

$$\text{MB degradation efficiency} = \left(1 - \frac{C_t}{C_0}\right) \times 100\%$$

where $C_0$ is the initial concentration of MB solution, and $C_t$ is the concentration of MB solution after visible light irradiation time.

3. Results and discussion

X-ray diffraction pattern of the as-deposited and annealed $WO_3$ thin films at different temperatures (823 K, 873 K, and 923 K) in air ambient for 1 h were shown in Fig. 1(a). In the case of as-deposited films, no peaks were detected which are associated with the $WO_3$ indicating that the amorphous nature of the films in the form of $WO_3-x$. This may be attributed to the room temperature deposition because the adatoms may not acquire enough energy to initiate their crystal lattice orientation on the glass substrates. After annealing, the films exhibited polycrystalline nature and all the peaks were associated to the
monoclinic phase of WO₃ corresponding to JCPDS 83-0950 (space group \( \text{P2}_1/\text{c} \); lattice parameters \( a = 7.3008 \) Å, \( b = 7.5389 \) Å, and \( c = 7.6896 \) Å; \( \beta = 90.892^\circ \)). The major XRD peak with a predominant reflection observed at \( 2\theta = 24.37^\circ \) corresponding with a preferred orientation (200) plane of monoclinic crystal structure, while the other peaks were indexed as (002), (020), (220), (222), (400), and (420) plane which are in good agreement with the previously reported sputter-deposited WO₃ films.\(^{44}\) X-ray diffraction pattern of Ag–WO₃/WO₃ films was shown in Fig. 1(b), the as-deposited films exhibited amorphous nature with no trace of XRD peaks. Irrespective of the annealing temperature, the preferred orientation (200) of WO₃ remains unchanged with the addition of Ag but diffraction peak intensity of the (002) plane corresponding to WO₃ became more intense for the annealed films.

Fig. 2 shows the surface morphology of the WO₃ films observed by FESEM at 50k× magnification. The surface morphology of as-deposited WO₃ thin film films exhibited densely packed nano-sized WO₃ grains. After annealing at 823 K, the densely packed amorphous films were crystallized with clear grain boundaries. By further increasing the annealing temperature to 923 K, non-uniform large polycrystalline grains were formed with increased grain boundaries, which could be plausibly due to the merging of small grains during the annealing process.

FESEM images of the WO₃/Ag–WO₃ thin films annealed at different temperatures were shown in Fig. 3. The as-deposited
films exhibited smooth surface morphology. However, very small nanorod-like structures were observed on the surface of the WO$_3$/Ag–WO$_3$ films annealed at 823 K. Nevertheless, it can be observed that the morphology of these nanorod-like structure was evolved in the type of nanosheet at 873 K and they became much more defined as the annealing temperature increased to 923 K. In addition, the surface morphology of 873 K annealed films comprised of a large number of nanosheets with lower spatial distribution in comparison with the 923 K films. The nanosheet-like structure formation was plausible due to the outward diffusion of Ag through the grain boundaries of WO$_3$. From the surface morphology, it is evident that the 873 K films possess small grain boundaries of WO$_3$ compared to the 923 K films. Thus, the presence of nanosheets over the 873 K films surface is much higher than 923 K films. Kumar et al. reported that the grain boundary diffusivity of the metal at metal/oxide interface is extremely fast, which supports for the formation of Ag nanostructures over the surface of WO$_3$. With an increase in annealing temperature to 873 K, the diffused nanosheet-like Ag$_2$O structures were drastically changed into the randomly oriented collectively grown nanosheet due to the agglomeration and grain growth of similar nanosheet-like structures. The evolution of nanosheets was continued to grow anisotropically because various crystal plane directions can be collectively grown and dominated due to the difference in the grain growth rates along that particular direction which leads to the possible shapes of the Ag nanostructures such as sheet-like, plate-like and rod-like shapes.

Obviously, the directional growth of nanosheets observed in FESEM surface morphology images of the WO$_3$/Ag–WO$_3$ films annealed at 823 to 973 K reflects that the Ag grain growth was definite which also represent the oxidation possibility of the Ag. The formation of Ag–O during the deposition of initial layer Ag–WO$_3$ on quartz substrate can be inevitable and the detailed mechanism can be explained as follows. Irradiation of high energetic Ar$^+$ at 45$^\circ$ could lead to the sputtering ejection of W, O, and Ag atoms from the Ag-chip embedded WO$_3$ target, which arrives at the substrate and the substrate get covered with the W, O, and Ag atoms depend on their sputtering yields. Fundamentally, this process involves adsorption, desorption, and diffusion of the sputter-deposited atoms, wherein the possibility of diffusion and clustering of the sputter-deposited atoms leads to the formation of Ag–O in the growing film. However, due to the low concentration of Ag and absence of substrate heating, Ag–O formation cannot be significant enough to exhibit crystallinity. Upon annealing the films in air ambient at high temperature, the amorphous Ag-doped WO$_3$ phase was transformed to crystalline Ag$_2$O + WO$_3$ phase, agglomeration and outward diffusion of Ag$_2$O was pronounced to form large grains in the form of Ag$_2$O nanosheets through the WO$_3$ grain boundaries. Thus, the Ag$_2$O/WO$_3$ composite phase formation could be observed in the WO$_3$/Ag–WO$_3$ films after annealing at high temperatures.

For a more detailed understanding of the evolution of collectively grown Ag$_2$O nanosheets, thin film cross-section of the WO$_3$/Ag–WO$_3$ after and before annealing was observed as shown in Fig. 4. As shown in Fig. 4(a), the as-deposited films exhibited a very clear interface between Ag–WO$_3$ and WO$_3$ layers. The evolution of collectively grown nanosheets can be clearly observed from the FESEM cross-section image Fig. 4(b). Obviously, the interface between the substrate and thin film is intact which indicates good adhesion of the annealed films at 923 K, while the interface of WO$_3$ and Ag–WO$_3$ was disappeared due to the mixing of WO$_3$ phases and outward diffusion of Ag during the annealing process. In order to confirm the existence of Ag, the WO$_3$/Ag–WO$_3$ films annealed at 923 K were subjected to FESEM EDS (energy dispersive X-ray spectrometry) analysis and respective elemental mapping along with elemental distribution of Ag and W were shown in Fig. 4(c). Thus, the elemental mapping substantiated that the final microstructure of the films comprised of collectively grown Ag$_2$O nanosheets embedded WO$_3$ composite structure.

The structure of the WO$_3$/Ag–WO$_3$ films annealed at 923 K was further characterized by TEM analysis. Fig. 5(a) shows the cross-section microstructure, which confirms the formation of nanocrystalline WO$_3$ grains. Fig. 5(b) shows the selected area electron diffraction (SAED) pattern indexed properly with the monoclinic structure of WO$_3$. As shown in Fig. 5(c), the high-resolution TEM (HR-TEM) image revealed the clear lattice fringes with an interplanar spacing about 0.364 and 0.376 nm which are corresponding to the (200) and (020) planes of the monoclinic–WO$_3$, respectively. Darkfield STEM (DF STEM) elemental scanning images obtained from the EDX exhibit the distribution of the constituted elements W, O, and Ag as shown in Fig. 5(d). The presence of a substantial amount of Ag across the WO$_3$ layer confirmed the outward diffusion of Ag through WO$_3$ grain boundaries. These results are in good accordance with the results observed by the FESEM analysis (Fig. 4(c)).

Optical absorbance spectra of the films were measured in the UV-vis region of wavelength range 300 to 900 nm. The optical bandgap was evaluated by using the following equation:

$$\alpha hv = A(hv - E_g)^n$$
where $h\nu$ is the energy of the incident photon, $\times$ is the absorption coefficient, $A$ is the absorption edge width parameter, and $E_g$ is the optical energy bandgap. The $n$ values are $1/2$, $3/2$, 2, or 3 for being direct and allowed transitions, direct and forbidden transitions, indirect and allowed transitions, and indirect and forbidden transitions, respectively.\textsuperscript{34} In the case of WO$_3$, the valence band is completely dominated by the O p states, and the bottom of the conduction band is mostly constituted by W d orbitals, due to this reason the transitions are allowed. Moreover, the bandgap is indirect so that the $n$ value 2 was taken to calculate the optical bandgap using the Tauc’s plot.\textsuperscript{33,35,36} Fig. 6 shows the absorbance spectra and $(\alpha h\nu)^{1/2}$ vs. $h\nu$ plots for pure WO$_3$ and WO$_3$/Ag–WO$_3$ films, the linear extrapolation of the plot to $h\nu = 0$ provides the bandgap value. The bandgap of the WO$_3$ films was calculated to be around 2.75 eV, while the WO$_3$/Ag–WO$_3$ films were estimated to

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**Fig. 5** TEM images of WO$_3$/Ag–WO$_3$ films annealed at 923 K: (a) cross-sectional microstructure, (b) SAED pattern of WO$_3$, (c) HR-TEM image with clear crystalline planes of monoclinic–WO$_3$ phase, and (d) DF STEM image and corresponding EDX elemental distribution of W, O, and Ag.

**Fig. 6** $(\alpha h\nu)^{1/2}$ vs. $h\nu$ plots and absorbance spectra of the WO$_3$ films (a), and WO$_3$/Ag–WO$_3$ films (b); optical transmittance spectra of the as-deposited and annealed WO$_3$/Ag–WO$_3$ films (c).
be about 2.5 eV. Optical transmittance spectra of the WO₃/Ag–WO₃ thin films were shown in Fig. 6(c). Obviously, the as-deposited WO₃/Ag–WO₃ films showed low transmittance due to the existence of amorphous Ag-doped WO₃ bottom layer. While the annealed films (at 823 to 923 K) exhibited high transmittance due to the oxidation of Ag which leads to the formation of Ag₂O/WO₃ composite phase. The films annealed at 823, 873, and 923 K exhibited an optical transmittance of 39, 79, and 66%, respectively. Transmittance of the films slightly decreased at high temperature (923 K), which can be due to the dominant light scattering from the film surface originated by the Ag₂O nanosheets. As the films are transparent in the visible region, the films are even adequate for the application of transparent air-purification window glazing systems.

The surface chemical states and compositions of the as-deposited and annealed (923 K) WO₃/Ag–WO₃ films were analysed by using the X-ray photoelectron spectroscopy. The XPS full-scan survey spectrum of the films was shown in Fig. 7(a), the annealed films clearly exhibit the presence of Ag, W, O peaks, and the as-deposited films show W and O peaks. High-resolution XPS spectra of W 4f were deconvoluted and shown in Fig. 7(b), the spin–orbit doublet for W valence state i.e. W 4f½/2 and 4f½/2 are attributed to the binding energy values of 38.07 and 36.14, 34.55 eV, respectively.²⁵ The doublet 4f½/2 and 4f½/2 splitting is 2.13 eV, position and shape of the peaks appeared (38.07 and 36.14 eV) were representative of an oxidation state of W⁶⁺ for the WO₃ phase.²⁵ As shown in Fig. 7(c), the oxygen 1s peak occurred in the as-deposited films at 531.0 eV corresponding to WO₃ and 532.1 eV attributed to the hydroxylation (W–OH).²⁸ In the case of annealed films, the peaks at 35.21 and 33.86 eV are corresponding to the W 4f½/2, and 37.16 eV belongs to the W 4f½/2 (Fig. 7(d)). The spin–orbit splitting is 2.1 eV with peaks area ratio 3 : 4 for W 4f½/2 and 4f½/2. The O 1s peak centred at 530.5 eV is ascribed to the formation of a strong W=O bond.⁴⁶ In contrast, based on the fitting of W 4f peaks, the annealed films consist of 84% of the W⁶⁺ while compared to the as-deposited films which show only 64%. Such an observation indicates that the annealed films comprised of the stoichiometric WO₃ phase, while the as-deposited films are under-stoichiometric WO₃–x phase with higher surface oxygen vacancies. The doublet of Ag 3d was deconvoluted as shown in Fig. 7(f). The peaks identified at 367.5, 368.1 and 373.6 eV were assigned to the Ag 3d½/2 and Ag 3d½/2 of Ag in Ag₂O, respectively. The splitting of the Ag 3d doublet was 6.0 eV, which indicates that the Ag exists in the form of the Ag₂O phase.

The photocatalytic activities of the WO₃ and WO₃/Ag–WO₃ (i.e. Ag₂O/WO₃ composite) films were evaluated by determining the photodegradation of the methylene blue under the irradiation of visible light, the photocatalytic performance was shown in Fig. 8(a). Annealed films at 923 K for 30 min in air ambient, which are in the monoclinic phase were utilized for the evaluation of the photocatalytic activity. The pseudo-first-order kinetic equation was used to calculate the reaction rate constant (k).

\[
\ln \left( \frac{C_0}{C} \right) = k \times t
\]

The reaction rate constant (k) of WO₃ and Ag₂O/WO₃ composite films are 2.39 × 10⁻² min⁻¹ and 0.915 × 10⁻² min⁻¹, respectively. The Ag₂O nanosheets embedded WO₃ composite films exhibited 2.61 times higher photocatalytic activity than that of pure WO₃ films. The obtained results clearly
demonstrated that the Ag$_2$O nanosheets exhibited a vital effect on the photocatalytic activity of WO$_3$ films, which can be due to the formation of p–n heterojunction Ag$_2$O of WO$_3$. A schematic of Ag$_2$O/WO$_3$ was shown in Fig. 8(b), p–n heterojunction forms when p-type Ag$_2$O and n-type WO$_3$ were contacted, the net electrons will migrate into Ag$_2$O from WO$_3$ while the net holes will migrate from WO$_3$ to Ag$_2$O until the Fermi level reaches equilibrium conditions ($E_f = 0.807$ eV). Because of these electron and hole migration, an electric field built at the interface between Ag$_2$O and WO$_3$. Under the irradiation of visible light, not only WO$_3$ generates electron–hole pairs but the narrow bandgap Ag$_2$O ($E_g = 1.4$ eV) also excites to generate electron–hole pairs. Due to the existence of the barrier between the Ag$_2$O and WO$_3$ heterojunction, the migration of photo-generated charge carriers would be promoted as shown in the schematic Fig. 8(b). Consequently, the probability of charge carrier recombination can be decreased, and a large number of holes can be accumulated on the Ag$_2$O while the electrons can be concentrated on WO$_3$. The pure WO$_3$ shows very little (~20%) degradation of the pollutants due to relatively lower conduction band edge of WO$_3$ (+0.3–0.5 V vs. NHE) which is insufficient to provide the required potential for the single-electron reduction of O$_2$ [EO$_2$/O$_2$ = −0.33 V vs. NHE; EO$_2$/HO$_2$ = −0.55 V vs. NHE]. In the case of Ag$_2$O/WO$_3$ p–n heterojunction, the electrons accumulated at conduction band of WO$_3$ would be transferred to surface-adsorbed oxygen molecules to form H$_2$O$_2$ by multi-electron reduction of O$_2$. The photoinduced holes with high oxidation potential (+3.1 V vs. NHE) are apt to react with surface-bound H$_2$O or OH$^-$ to produce hydroxyl radical species 'OH which is extremely strong oxidant for the degradation of organic contaminants. Thus, the photocatalytic reactions would be triggered to decompose the methylene blue with enhanced photocatalytic activity in WO$_3$/Ag–WO$_3$ films annealed at 923 K. The enhanced photocatalytic activity associates with the reduction of recombination rate of photogenerated charge carriers. Therefore, to determine the charge migration and extent of electron–hole pair recombination i.e. electron–hole pair separation ability, the photoluminescence spectra of the WO$_3$/Ag–WO$_3$ films was studied as shown in Fig. 8(c). As shown in the figure, the emission ranges between 375–600 nm. The emission of photons resulting from the electron–hole pair recombination gives the photoluminescence spectra. In general, the sample with high luminous peak intensity represents the faster recombination of electron–hole pairs in that sample, whereas the sample with low luminous peak intensity represents the prolonged life-time of the photogenerated charge carriers. Therefore, the high intensity of the emission peaks for as-deposited annealed films below 873 K corresponds to higher charge carrier recombination. These strong emission peaks are induced by the electron–hole radiation recombination due to the de-excitation from W$^{6+}$ to O$^2$$. The films annealed at 923 K exhibit lower emission peak intensity which indicate the lowest charge carrier recombination among all the films. Therefore, the Ag$_2$O/WO$_3$ composite films in which Ag$_2$O nanosheets were homogeneously embedded in WO$_3$ exhibited significant photocatalytic activity is ascribed to the efficient charge transfer process in the films. Thus, the films offer a superior photocatalytic activity than that of pure WO$_3$ films. Although this Ag$_2$O/WO$_3$ thin film composite p–n heterojunction structure has attained better photocatalytic activity than pure WO$_3$, further study is required to achieve high photocatalytic activity to compete with powder-based photocatalysts because true potential of this structure is fully unrealized due to the reason of low available surface area for the photocatalytic reaction. This work would provide a sustainable,
4. Conclusions

Semiconductor photocatalysts of p-type Ag₂O and n-type WO₃ were suitably designed to form thin film p–n heterojunction by RF magnetron sputtering and subsequent annealing of Ag₂O/WO₃ thin films for the application of visible-light photocatalysis. Upon annealing, the amorphous WO₃ was converted to monoclinic WO₃. Thin film surface and cross-section observations revealed that the Ag₂O has been diffused outward towards the surface of WO₃, the chemical composition investigated by XPS also confirmed the existence of the Ag₂O phase on WO₃ surface. The Ag₂O/WO₃ composite films obtained after annealing at 923 K exhibited about 66% transmittance in the visible region, and the photoluminescence emission spectra results revealed that the films possess lowest electron–hole recombination rate among all the films. The photocatalytic activity of the obtained Ag₂O/WO₃ p–n heterojunction thin film composed of Ag₂O nanosheets embedded WO₃ composite was evaluated by degradation of MB solution under visible light, the films exhibited 2.61 times higher photocatalytic activity than that of pure WO₃ films with a photocatalytic activity rate constant of 0.915 × 10⁻³ min⁻¹. The enhanced photocatalytic activity of p–n heterojunction attributed to the good visible light absorption and efficient separation of photogenerated electron–hole pairs. This work provides a unique approach to design optically transparent, environmentally sustainable, reusable, simple and cost-effective thin film p–n heterojunction photocatalysts with better photocatalytic activity for visible-light photocatalysis by controlling the separation of photogenerated electron–hole pairs and homogeneous distribution of photocatalysts in nano-size.

Conflicts of interest

There are no conflicts to declare.

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Notes and references
